

Programmable controllers -- Part 9: Single-drop digital communication interface for small sensors and actuators (SDCI)

EESTI STANDARDI EESSÕNA

NATIONAL FOREWORD

See Eesti standard EVS-EN 61131-9:2013 sisaldab Euroopa standardi EN 61131-9:2013 inglisekeelset teksti.	This Estonian standard EVS-EN 61131-9:2013 consists of the English text of the European standard EN 61131-9:2013.
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**Programmable controllers -
Part 9: Single-drop digital communication interface for small sensors and
actuators (SDCI)
(IEC 61131-9:2013)**

Automates programmables -
Partie 9: Interface de communication
numérique point à point pour petits
capteurs et actionneurs (SDCI)
(CEI 61131-9:2013)

Speicherprogrammierbare Steuerungen -
Teil 9: Schnittstelle für die Kommunikation
mit kleinen Sensoren und Aktoren über
eine Punkt-zu-Punkt-Verbindung
(IEC 61131-9:2013)

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Foreword

The text of document 65B/874/FDIS, future edition 1 of IEC 61131-9, prepared by SC 65B, "Measurement and control devices", of IEC/TC 65, "Industrial-process measurement, control and automation" was submitted to the IEC-CENELEC parallel vote and approved by CENELEC as EN 61131-9:2013.

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- latest date by which the national standards conflicting with the document have to be withdrawn (dow) 2016-10-16

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Endorsement notice

The text of the International Standard IEC 61131-9:2013 was approved by CENELEC as a European Standard without any modification.

In the official version, for Bibliography, the following notes have to be added for the standards indicated:

IEC 60870-5-1:1990	NOTE	Harmonised as EN 60870-5-1:1993 (not modified).
IEC 61158-2	NOTE	Harmonised as EN 61158-2 (not modified).
IEC/TR 62453-61	NOTE	Harmonised as CLC/TR 62453-61 (not modified).
ISOIEC 7498-1	NOTE	Harmonised as EN ISOIEC 7498-1 (not modified).

Annex ZA (normative)

Normative references to international publications with their corresponding European publications

The following referenced documents are indispensable for the application of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

NOTE When an international publication has been modified by common modifications, indicated by (mod), the relevant EN/HD applies.

<u>Publication</u>	<u>Year</u>	<u>Title</u>	<u>EN/HD</u>	<u>Year</u>
IEC 60947-5-2	-	Low-voltage switchgear and controlgear - Part 5-2: Control circuit devices and switching elements - Proximity switches	EN 60947-5-2	-
IEC 61000-4-2	-	Electromagnetic compatibility (EMC) - Part 4-2: Testing and measurement techniques - Electrostatic discharge immunity test	EN 61000-4-2	-
IEC 61000-4-3	-	Electromagnetic compatibility (EMC) - Part 4-3: Testing and measurement techniques - Radiated, radio-frequency, electromagnetic field immunity test	EN 61000-4-3	-
IEC 61000-4-4	-	Electromagnetic compatibility (EMC) - Part 4-4: Testing and measurement techniques - Electrical fast transient/burst immunity test	EN 61000-4-4	-
IEC 61000-4-5	-	Electromagnetic compatibility (EMC) - Part 4-5: Testing and measurement techniques - Surge immunity test	FprEN 61000-4-5	-
IEC 61000-4-6	-	Electromagnetic compatibility (EMC) - Part 4-6: Testing and measurement techniques - Immunity to conducted disturbances, induced by radio-frequency fields	FprEN 61000-4-6	-
IEC 61000-4-11	-	Electromagnetic compatibility (EMC) - Part 4-11: Testing and measurement techniques - Voltage dips, short interruptions and voltage variations immunity tests	EN 61000-4-11	-
IEC 61000-6-2	-	Electromagnetic compatibility (EMC) - Part 6-2: Generic standards - Immunity for industrial environments	EN 61000-6-2 + corr. September	-
IEC 61000-6-4	-	Electromagnetic compatibility (EMC) - Part 6-4: Generic standards - Emission standard for industrial environments	EN 61000-6-4	-
IEC 61076-2-101	-	Connectors for electronic equipment - Product requirements - Part 2-101: Circular connectors - Detail specification for M12 connectors with screw-locking	EN 61076-2-101	-
IEC 61131-1	-	Programmable controllers - Part 1: General information	EN 61131-1	-

<u>Publication</u>	<u>Year</u>	<u>Title</u>	<u>EN/HD</u>	<u>Year</u>
IEC 61131-2	-	Programmable controllers - Part 2: Equipment requirements and tests	EN 61131-2 ¹⁾	-
IEC/TR 62390	-	Common automation device - Profile guideline	-	-
ISO/IEC 646	1991	Information technology - ISO 7-bit coded character set for information interchange	-	-
ISO/IEC 2022	-	Information technology - Character code structure and extension techniques	-	-
ISO/IEC 10646	-	Information technology - Universal Coded Character Set (UCS)	-	-
ISO/IEC 10731	-	Information technology - Open Systems Interconnection - Basic reference model - Conventions for the definition of OSI services	-	-
ISO 1177	-	Information processing - Character structure for start/stop and synchronous character-oriented transmission	-	-
IEEE 754	2008	Binary floating-point arithmetic	-	-

¹⁾ EN 61131-2 is superseded by EN 61010-2-201:2013, which is based on IEC 61010-2-201:2013.

CONTENTS

FOREWORD.....	14
INTRODUCTION.....	16
1 Scope.....	18
2 Normative references	18
3 Terms, definitions, symbols, abbreviated terms and conventions	19
3.1 Terms and definitions	19
3.2 Symbols and abbreviated terms.....	23
3.3 Conventions	25
3.3.1 General	25
3.3.2 Service parameters	25
3.3.3 Service procedures.....	26
3.3.4 Service attributes	26
3.3.5 Figures	26
3.3.6 Transmission octet order	26
3.3.7 Behavioral descriptions	27
4 Overview of SDCI (IO-Link™)	27
4.1 Purpose of technology.....	27
4.2 Positioning within the automation hierarchy	28
4.3 Wiring, connectors and power	29
4.4 Communication features of SDCI.....	29
4.5 Role of a Master.....	31
4.6 SDCI configuration	32
4.7 Mapping to fieldbuses	32
4.8 Standard structure.....	32
5 Physical Layer (PL)	33
5.1 General	33
5.1.1 Basics	33
5.1.2 Topology	33
5.2 Physical layer services	34
5.2.1 Overview	34
5.2.2 PL services.....	35
5.3 Transmitter/Receiver	37
5.3.1 Description method.....	37
5.3.2 Electrical requirements	37
5.3.3 Timing requirements	41
5.4 Power supply.....	44
5.4.1 Power supply options	44
5.4.2 Power-on requirements.....	45
5.5 Medium	45
5.5.1 Connectors	45
5.5.2 Cable.....	47
6 Standard Input and Output (SIO)	48
7 Data link layer (DL)	48
7.1 General	48
7.2 Data link layer services	50
7.2.1 DL-B services	50

7.2.2	DL-A services	61
7.3	Data link layer protocol.....	66
7.3.1	Overview	66
7.3.2	DL-mode handler	67
7.3.3	Message handler	75
7.3.4	Process Data handler	82
7.3.5	On-request Data handler	85
7.3.6	ISDU handler	88
7.3.7	Command handler	92
7.3.8	Event handler	95
8	Application layer (AL)	98
8.1	General	98
8.2	Application layer services	99
8.2.1	AL services within Master and Device.....	99
8.2.2	AL Services	100
8.3	Application layer protocol	108
8.3.1	Overview	108
8.3.2	On-request Data transfer	108
8.3.3	Event processing	114
8.3.4	Process Data cycles	117
9	System management (SM)	118
9.1	General	118
9.2	System management of the Master	118
9.2.1	Overview	118
9.2.2	SM Master services	120
9.2.3	SM Master protocol	125
9.3	System management of the Device	133
9.3.1	Overview	133
9.3.2	SM Device services	135
9.3.3	SM Device protocol	141
10	Device	148
10.1	Overview	148
10.2	Process Data Exchange (PDE)	149
10.3	Parameter Manager (PM)	149
10.3.1	General	149
10.3.2	Parameter manager state machine	149
10.3.3	Dynamic parameter	151
10.3.4	Single parameter	152
10.3.5	Block parameter	153
10.3.6	Concurrent parameterization access	155
10.3.7	Command handling	155
10.4	Data Storage (DS)	155
10.4.1	General	155
10.4.2	Data Storage state machine	155
10.4.3	DS configuration	157
10.4.4	DS memory space	157
10.4.5	DS Index_List	158
10.4.6	DS parameter availability	158
10.4.7	DS without ISDU	158

10.4.8	DS parameter change indication	158
10.5	Event Dispatcher (ED).....	158
10.6	Device features	158
10.6.1	General	158
10.6.2	Device backward compatibility	159
10.6.3	Protocol revision compatibility	159
10.6.4	Factory settings	159
10.6.5	Application reset.....	159
10.6.6	Device reset	159
10.6.7	Visual SDCI indication	159
10.6.8	Parameter access locking.....	160
10.6.9	Data Storage locking	160
10.6.10	Device parameter locking	160
10.6.11	Device user interface locking	160
10.6.12	Offset time.....	160
10.6.13	Data Storage concept	161
10.6.14	Block Parameter	161
10.7	Device design rules and constraints	161
10.7.1	General	161
10.7.2	Process Data.....	161
10.7.3	Communication loss	161
10.7.4	Direct Parameter	161
10.7.5	ISDU communication channel.....	162
10.7.6	DeviceID rules related to Device variants	162
10.7.7	Protocol constants.....	162
10.8	IO Device description (IODD)	163
10.9	Device diagnosis	163
10.9.1	Concepts	163
10.9.2	Events	164
10.9.3	Visual indicators	165
10.10	Device connectivity	166
11	Master	166
11.1	Overview.....	166
11.1.1	Generic model for the system integration of a Master	166
11.1.2	Structure and services of a Master	166
11.2	Configuration Manager (CM)	169
11.2.1	General	169
11.2.2	Configuration parameter	171
11.2.3	State machine of the Configuration Manager	173
11.3	Data Storage (DS).....	175
11.3.1	Overview	175
11.3.2	DS data object.....	175
11.3.3	DS state machine	175
11.3.4	Parameter selection for Data Storage	181
11.4	On-Request Data exchange (ODE).....	181
11.5	Diagnosis Unit (DU).....	182
11.6	PD Exchange (PDE).....	183
11.6.1	General	183
11.6.2	Process Data mapping.....	183

11.6.3 Process Data invalid/valid qualifier status	184
11.7 Port and Device configuration tool (PDCT)	185
11.7.1 General	185
11.7.2 Basic layout examples	185
11.8 Gateway application	186
11.8.1 General	186
11.8.2 Changing Device configuration including Data Storage	186
11.8.3 Parameter server and recipe control	186
11.8.4 Anonymous parameters	186
11.8.5 Virtual port mode DIwithSDCI	187
Annex A (normative) Codings, timing constraints, and errors	190
Annex B (normative) Parameter and commands	211
Annex C (normative) ErrorTypes (ISDU errors)	228
Annex D (normative) EventCodes (diagnosis information)	233
Annex E (normative) Data types	236
Annex F (normative) Structure of the Data Storage data object	247
Annex G (normative) Master and Device conformity	248
Annex H (informative) Residual error probabilities	254
Annex I (informative) Example sequence of an ISDU transmission	256
Annex J (informative) Recommended methods for detecting parameter changes	258
Bibliography	259
Figure 1 – Example of a confirmed service	26
Figure 2 – Memory storage and transmission order for WORD based data types	27
Figure 3 – SDCI compatibility with IEC 61131-2	27
Figure 4 – Domain of the SDCI technology within the automation hierarchy	28
Figure 5 – Generic Device model for SDCI (Master's view)	29
Figure 6 – Relationship between nature of data and transmission types	30
Figure 7 – Object transfer at the application layer level (AL)	31
Figure 8 – Logical structure of Master and Device	32
Figure 9 – Three wire connection system	33
Figure 10 – Topology of SDCI	34
Figure 11 – Physical layer (Master)	34
Figure 12 – Physical layer (Device)	35
Figure 13 – Line driver reference schematics	37
Figure 14 – Receiver reference schematics	37
Figure 15 – Reference schematics for SDCI 3-wire connection system	38
Figure 16 – Voltage level definitions	38
Figure 17 – Switching thresholds	39
Figure 18 – Format of an SDCI UART frame	41
Figure 19 – Eye diagram for the 'H' and 'L' detection	42
Figure 20 – Eye diagram for the correct detection of a UART frame	42
Figure 21 – Wake-up request	44
Figure 22 – Power-on timing for Power1	45

Figure 23 – Pin layout front view	46
Figure 24 – Class A and B port definitions	47
Figure 25 – Reference schematic for effective line capacitance and loop resistance	47
Figure 26 – Structure and services of the data link layer (Master)	49
Figure 27 – Structure and services of the data link layer (Device)	49
Figure 28 – State machines of the data link layer	67
Figure 29 – Example of an attempt to establish communication	67
Figure 30 – Failed attempt to establish communication	68
Figure 31 – Retry strategy to establish communication	68
Figure 32 – Fallback procedure	69
Figure 33 – State machine of the Master DL-mode handler	70
Figure 34 – Submachine 1 to establish communication	71
Figure 35 – State machine of the Device DL-mode handler	73
Figure 36 – SDCI message sequences	75
Figure 37 – Overview of M-sequence types	76
Figure 38 – State machine of the Master message handler	77
Figure 39 – Submachine "Response 3" of the message handler	78
Figure 40 – Submachine "Response 8" of the message handler	78
Figure 41 – Submachine "Response 15" of the message handler	78
Figure 42 – State machine of the Device message handler	81
Figure 43 – Interleave mode for the segmented transmission of Process Data	83
Figure 44 – State machine of the Master Process Data handler	83
Figure 45 – State machine of the Device Process Data handler	85
Figure 46 – State machine of the Master On-request Data handler	86
Figure 47 – State machine of the Device On-request Data handler	87
Figure 48 – Structure of the ISDU	88
Figure 49 – State machine of the Master ISDU handler	90
Figure 50 – State machine of the Device ISDU handler	91
Figure 51 – State machine of the Master command handler	93
Figure 52 – State machine of the Device command handler	94
Figure 53 – State machine of the Master Event handler	96
Figure 54 – State machine of the Device Event handler	97
Figure 55 – Structure and services of the application layer (Master)	98
Figure 56 – Structure and services of the application layer (Device)	99
Figure 57 – OD state machine of the Master AL	109
Figure 58 – OD state machine of the Device AL	110
Figure 59 – Sequence diagram for the transmission of On-request Data	112
Figure 60 – Sequence diagram for On-request Data in case of errors	113
Figure 61 – Sequence diagram for On-request Data in case of timeout	113
Figure 62 – Event state machine of the Master AL	114
Figure 63 – Event state machine of the Device AL	115
Figure 64 – Single Event scheduling	116
Figure 65 – Sequence diagram for output Process Data	117

Figure 66 – Sequence diagram for input Process Data.....	118
Figure 67 – Structure and services of the Master system management	119
Figure 68 – Sequence chart of the use case "port x setup"	120
Figure 69 – Main state machine of the Master system management.....	126
Figure 70 – SM Master submachine CheckCompatibility_1	128
Figure 71 – Activity for state "CheckVxy"	130
Figure 72 – Activity for state "CheckCompV10".....	130
Figure 73 – Activity for state "CheckComp".....	131
Figure 74 – Activity (write parameter) in state "RestartDevice".....	131
Figure 75 – SM Master submachine CheckSerNum_3.....	132
Figure 76 – Activity (check SerialNumber) for state CheckSerNum_3.....	133
Figure 77 – Structure and services of the system management (Device).....	134
Figure 78 – Sequence chart of the use case "INACTIVE – SIO – SDCI – SIO"	135
Figure 79 – State machine of the Device system management.....	142
Figure 80 – Sequence chart of a regular Device startup.....	145
Figure 81 – Sequence chart of a Device startup in compatibility mode	146
Figure 82 – Sequence chart of a Device startup when compatibility fails.....	147
Figure 83 – Structure and services of a Device	148
Figure 84 – The Parameter Manager (PM) state machine	150
Figure 85 – Positive and negative parameter checking result	152
Figure 86 – Positive block parameter download with Data Storage request.....	153
Figure 87 – Negative block parameter download.....	154
Figure 88 – The Data Storage (DS) state machine.....	156
Figure 89 – Data Storage request message sequence	157
Figure 90 – Cycle timing	160
Figure 91 – Event flow in case of successive errors.....	165
Figure 92 – Device LED indicator timing	165
Figure 93 – Generic relationship of SDCI technology and fieldbus technology	166
Figure 94 – Structure and services of a Master	168
Figure 95 – Relationship of the common Master applications	168
Figure 96 – Sequence diagram of configuration manager actions.....	170
Figure 97 – Ports in MessageSync mode	171
Figure 98 – State machine of the Configuration Manager	173
Figure 99 – Main state machine of the Data Storage mechanism	175
Figure 100 – Submachine "UpDownload_2" of the Data Storage mechanism	176
Figure 101 – Data Storage submachine "Upload_7"	177
Figure 102 – Data Storage upload sequence diagram	177
Figure 103 – Data Storage submachine "Download_10".....	178
Figure 104 – Data Storage download sequence diagram.....	178
Figure 105 – State machine of the On-request Data Exchange	181
Figure 106 – System overview of SDCI diagnosis information propagation via Events	183
Figure 107 – Process Data mapping from ports to the gateway data stream.....	184
Figure 108 – Propagation of PD qualifier status between Master and Device	184

Figure 109 – Example 1 of a PDCT display layout.....	185
Figure 110 – Example 2 of a PDCT display layout.....	186
Figure 111 – Alternative Device configuration	187
Figure 112 – Virtual port mode "DIwithSDCI"	188
Figure A.1 – M-sequence control	190
Figure A.2 – Checksum/M-sequence type octet	191
Figure A.3 – Checksum/status octet.....	192
Figure A.4 – Principle of the checksum calculation and compression	193
Figure A.5 – M-sequence TYPE_0	194
Figure A.6 – M-sequence TYPE_1_1	194
Figure A.7 – M-sequence TYPE_1_2	195
Figure A.8 – M-sequence TYPE_1_V	195
Figure A.9 – M-sequence TYPE_2_1	196
Figure A.10 – M-sequence TYPE_2_2	196
Figure A.11 – M-sequence TYPE_2_3	196
Figure A.12 – M-sequence TYPE_2_4	197
Figure A.13 – M-sequence TYPE_2_5	197
Figure A.14 – M-sequence TYPE_2_6	197
Figure A.15 – M-sequence TYPE_2_V	198
Figure A.16 – M-sequence timing.....	201
Figure A.17 – I-Service octet	203
Figure A.18 – Check of ISDU integrity via CHKPDU.....	205
Figure A.19 – Examples of request formats for ISDUs.....	206
Figure A.20 – Examples of response ISDUs.....	206
Figure A.21 – Examples of read and write request ISDUs	207
Figure A.22 – Structure of StatusCode type 1	208
Figure A.23 – Structure of StatusCode type 2	208
Figure A.24 – Indication of activated Events	209
Figure A.25 – Structure of the EventQualifier	209
Figure B.1 – Classification and mapping of Direct Parameters	211
Figure B.2 – MinCycleTime.....	213
Figure B.3 – M-sequence Capability	214
Figure B.4 – RevisionID	215
Figure B.5 – ProcessDataIn	215
Figure B.6 – Index space for ISDU data objects	217
Figure B.7 – Structure of the Offset Time.....	226
Figure E.1 – Coding examples of UIntegerT	237
Figure E.2 – Coding examples of IntegerT	239
Figure E.3 – Singular access of StringT	240
Figure E.4 – Coding example of OctetStringT	241
Figure E.5 – Definition of TimeT	241
Figure E.6 – Example of an ArrayT data structure.....	243
Figure E.7 – Example 2 of a RecordT structure.....	245

Figure E.8 – Example 3 of a RecordT structure	245
Figure E.9 – Write requests for example 3	246
Figure G.1 – Test setup for electrostatic discharge (Master)	250
Figure G.2 – Test setup for RF electromagnetic field (Master)	250
Figure G.3 – Test setup for fast transients (Master)	251
Figure G.4 – Test setup for RF common mode (Master)	251
Figure G.5 – Test setup for electrostatic discharges (Device)	252
Figure G.6 – Test setup for RF electromagnetic field (Device)	252
Figure G.7 – Test setup for fast transients (Device)	252
Figure G.8 – Test setup for RF common mode (Device)	253
Figure H.1 – Residual error probability for the SDCI data integrity mechanism	254
Figure I.1 – Example for ISDU transmissions (1 of 2)	256
Table 1 – Service assignments of Master and Device	35
Table 2 – PL_SetMode	35
Table 3 – PL_WakeUp	36
Table 4 – PL_Transfer	36
Table 5 – Electric characteristics of a receiver	39
Table 6 – Electric characteristics of a Master port	39
Table 7 – Electric characteristics of a Device	40
Table 8 – Dynamic characteristics of the transmission	43
Table 9 – Wake-up request characteristics	44
Table 10 – Power-on timing	45
Table 11 – Pin assignments	46
Table 12 – Cable characteristics	47
Table 13 – Cable conductor assignments	48
Table 14 – Service assignments within Master and Device	50
Table 15 – DL_ReadParam	51
Table 16 – DL_WriteParam	51
Table 17 – DL_Read	52
Table 18 – DL_Write	53
Table 19 – DL_ISDUTransport	54
Table 20 – DL_ISDUAbort	55
Table 21 – DL_PDOutputUpdate	55
Table 22 – DL_PDOutputTransport	56
Table 23 – DL_PDInputUpdate	57
Table 24 – DL_PDInputTransport	57
Table 25 – DL_PDCycle	58
Table 26 – DL_SetMode	58
Table 27 – DL_Mode	59
Table 28 – DL_Event	60
Table 29 – DL_EventConf	60
Table 30 – DL_EventTrigger	61

Table 31 – DL_Control	61
Table 32 – DL-A services within Master and Device	62
Table 33 – OD	62
Table 34 – PD	63
Table 35 – EventFlag	64
Table 36 – PDInStatus	65
Table 37 – MHInfo	65
Table 38 – ODTrig	66
Table 39 – PDTrig	66
Table 40 – Wake-up procedure and retry characteristics	69
Table 41 – Fallback timing characteristics	70
Table 42 – State transition tables of the Master DL-mode handler	71
Table 43 – State transition tables of the Device DL-mode handler	74
Table 44 – State transition table of the Master message handler	79
Table 45 – State transition tables of the Device message handler	82
Table 46 – State transition tables of the Master Process Data handler	84
Table 47 – State transition tables of the Device Process Data handler	85
Table 48 – State transition tables of the Master On-request Data handler	86
Table 49 – State transition tables of the Device On-request Data handler	88
Table 50 – FlowCTRL definitions	89
Table 51 – State transition tables of the Master ISDU handler	90
Table 52 – State transition tables of the Device ISDU handler	92
Table 53 – Control codes	93
Table 54 – State transition tables of the Master command handler	93
Table 55 – State transition tables of the Device command handler	94
Table 56 – Event memory	95
Table 57 – State transition tables of the Master Event handler	96
Table 58 – State transition tables of the Device Event handler	97
Table 59 – AL services within Master and Device	99
Table 60 – AL_Read	100
Table 61 – AL_Write	101
Table 62 – AL_Abort	102
Table 63 – AL_GetInput	102
Table 64 – AL_NewInput	103
Table 65 – AL_SetInput	104
Table 66 – AL_PDCycle	104
Table 67 – AL_GetOutput	105
Table 68 – AL_NewOutput	105
Table 69 – AL_SetOutput	106
Table 70 – AL_Event	107
Table 71 – AL_Control	108
Table 72 – States and transitions for the OD state machine of the Master AL	109
Table 73 – States and transitions for the OD state machine of the Device AL	111

Table 74 – State and transitions of the Event state machine of the Master AL.....	114
Table 75 – State and transitions of the Event state machine of the Device AL.....	115
Table 76 – SM services within the Master	121
Table 77 – SM_SetPortConfig.....	121
Table 78 – Definition of the InspectionLevel (IL)	122
Table 79 – Definitions of the Target Modes	123
Table 80 – SM_GetPortConfig	123
Table 81 – SM_PortMode	124
Table 82 – SM_Operate	125
Table 83 – State transition tables of the Master system management	127
Table 84 – State transition tables of the Master submachine CheckCompatibility_1	128
Table 85 – State transition tables of the Master submachine CheckSerNum_3.....	132
Table 86 – SM services within the Device	136
Table 87 – SM_SetDeviceCom	136
Table 88 – SM_GetDeviceCom	137
Table 89 – SM_SetDeviceIdent.....	138
Table 90 – SM_GetDeviceIdent	139
Table 91 – SM_SetDeviceMode	140
Table 92 – SM_DeviceMode	141
Table 93 – State transition tables of the Device system management	142
Table 94 – State transition tables of the PM state machine	150
Table 95 – Definitions of parameter checks	152
Table 96 – State transition table of the Data Storage state machine	156
Table 97 – Overview of the protocol constants for Devices	162
Table 98 – Classification of Device diagnosis incidents.....	164
Table 99 – Timing for LED indicators	165
Table 100 – Internal variables and Events to control the common Master applications	169
Table 101 – State transition tables of the Configuration Manager.....	174
Table 102 – States and transitions of the Data Storage state machines	179
Table 103 – State transition table of the ODE state machine.....	181
Table 104 – State transitions of the state machine "DIwithSDCI"	188
Table A.1 – Values of communication channel	190
Table A.2 – Values of R/W	191
Table A.3 – Values of M-sequence types	191
Table A.4 – Data types for user data.....	192
Table A.5 – Values of PD status	192
Table A.6 – Values of the Event flag	193
Table A.7 – M-sequence types for the STARTUP mode	198
Table A.8 – M-sequence types for the PREOPERATE mode	198
Table A.9 – M-sequence types for the OPERATE mode (legacy protocol)	199
Table A.10 – M-sequence types for the OPERATE mode	199
Table A.11 – Recommended MinCycleTimes	201
Table A.12 – Definition of the nibble "I-Service"	203

Table A.13 – ISDU syntax	204
Table A.14 – Definition of nibble Length and octet ExtLength	204
Table A.15 – Use of Index formats	205
Table A.16 – Mapping of EventCodes (type 1)	208
Table A.17 – Values of INSTANCE	209
Table A.18 – Values of SOURCE	210
Table A.19 – Values of TYPE	210
Table A.20 – Values of MODE	210
Table B.1 – Direct Parameter page 1 and 2	212
Table B.2 – Types of MasterCommands	213
Table B.3 – Possible values of MasterCycleTime and MinCycleTime	214
Table B.4 – Values of ISDU	214
Table B.5 – Values of SIO	215
Table B.6 – Permitted combinations of BYTE and Length	215
Table B.7 – Implementation rules for parameters and commands	217
Table B.8 – Index assignment of data objects (Device parameter)	218
Table B.9 – Coding of SystemCommand (ISDU)	219
Table B.10 – Data Storage Index assignments	220
Table B.11 – Structure of Index_List	221
Table B.12 – Device locking possibilities	222
Table B.13 – Device status parameter	224
Table B.14 – Detailed Device Status (Index 0x0025)	225
Table B.15 – Time base coding and values of Offset Time	226
Table C.1 – ErrorTypes	228
Table C.2 – Derived ErrorTypes	231
Table D.1 – EventCodes	233
Table D.2 – Basic SDCI EventCodes	235
Table E.1 – BooleanT	236
Table E.2 – BooleanT coding	236
Table E.3 – UIntegerT	237
Table E.4 – IntegerT	237
Table E.5 – IntegerT coding (8 octets)	238
Table E.6 – IntegerT coding (4 octets)	238
Table E.7 – IntegerT coding (2 octets)	238
Table E.8 – IntegerT coding (1 octet)	238
Table E.9 – Float32T	239
Table E.10 – Coding of Float32T	239
Table E.11 – StringT	240
Table E.12 – OctetStringT	240
Table E.13 – TimeT	241
Table E.14 – Coding of TimeT	242
Table E.15 – TimeSpanT	242
Table E.16 – Coding of TimeSpanT	242

Table E.17 – Structuring rules for ArrayT	243
Table E.18 – Example for the access of an ArrayT	243
Table E.19 – Structuring rules for RecordT	244
Table E.20 – Example 1 for the access of a RecordT	244
Table E.21 – Example 2 for the access of a RecordT	244
Table E.22 – Example 3 for the access of a RecordT	245
Table F.1 – Structure of the stored DS data object.....	247
Table F.2 – Associated header information for stored DS data objects.....	247
Table G.1 – EMC test conditions for SDCI	248
Table G.2 – EMC test levels	249
Table J.1 – Proper CRC generator polynomials.....	258

INTRODUCTION

0.1 General

IEC 61131-9 is part of a series of standards on programmable controllers and the associated peripherals and should be read in conjunction with the other parts of the series.

Where a conflict exists between this and other IEC standards (except basic safety standards), the provisions of this standard should be considered to govern in the area of programmable controllers and their associated peripherals.

The increased use of micro-controllers embedded in low-cost sensors and actuators has provided opportunities for adding diagnosis and configuration data to support increasing application requirements.

The driving force for the SDCI (IO-Link™¹) technology is the need of these low-cost sensors and actuators to exchange this diagnosis and configuration data with a controller (PC or PLC) using a low-cost, digital communication technology while maintaining backward compatibility with the current DI/DO signals.

In fieldbus concepts, the SDCI technology defines a generic interface for connecting sensors and actuators to a Master unit, which may be combined with gateway capabilities to become a fieldbus remote I/O node.

Any SDCI compliant Device can be attached to any available interface port of the Master. SDCI compliant Devices perform physical to digital conversion in the Device, and then communicate the result directly in a standard format using "coded switching" of the 24 V I/O signalling line, thus removing the need for different DI, DO, AI, AO modules and a variety of cables.

Physical topology is point-to-point from each Device to the Master using 3 wires over distances up to 20 m. The SDCI physical interface is backward compatible with the usual 24 V I/O signalling specified in IEC 61131-2. Transmission rates of 4,8 kbit/s, 38,4 kbit/s and 230,4 kbit/s are supported.

The Master of the SDCI interface detects, identifies and manages Devices plugged into its ports.

Tools allow the association of Devices with their corresponding electronic I/O Device Descriptions (IODD) and their subsequent configuration to match the application requirements.

The SDCI technology specifies three different levels of diagnostic capabilities: for immediate response by automated needs during the production phase, for medium term response by operator intervention, or for longer term commissioning and maintenance via extended diagnosis information.

The structure of this standard is described in 4.8.

Conformity with IEC 61131-9 cannot be claimed unless the requirements of Annex G are met.

Terms of general use are defined in IEC 61131-1 or in the IEC 60050 series. More specific terms are defined in each part.

¹ IO-Link™ is a trade name of the "IO-Link Consortium". This information is given for the convenience of users of this international Standard and does not constitute an endorsement by IEC of the trade name holder or any of its products. Compliance to this standard does not require use of the registered logos for IO-Link™. Use of the registered logos for IO-Link™ requires permission of the "IO-Link Consortium".

0.2 Patent declaration

The International Electrotechnical Commission (IEC) draws attention to the fact that it is claimed that compliance with this document may involve the use of patents concerning the point-to-point serial communication interface for small sensors and actuators as follows, where the [xx] notation indicates the holder of the patent right:

DE 10030845B4 EP 1168271B1 US 6889282B2	[AB]	Fieldbus connecting system for actuators or sensors
EP 1203933 B1	[FE]	Sensor device for measuring at least one variable
DE 10 2004 035 831.1	[SI]	Operational status of a computer system is checked by comparison of actual parameters with reference values and modification to software if needed
DE 102 119 39 A1 US 2003/0200323 A1	[SK]	Coupling apparatus for the coupling of devices to a bus system

IEC takes no position concerning the evidence, validity and scope of these patent rights.

The holders of these patents rights have assured the IEC that they are willing to negotiate licences either free of charge or under reasonable and non-discriminatory terms and conditions with applicants throughout the world. In this respect, the statements of the holders of these patent rights are registered with IEC.

Information may be obtained from:

[AB]	ABB AG Heidelberg Germany
[FE]	Festo AG Esslingen Germany
[SI]	Siemens AG Otto-Hahn-Ring 6 81739 Munich Germany
[SK]	Sick AG Waldkirch Germany

Attention is drawn to the possibility that some of the elements of this document may be the subject of patent rights other than those identified above. IEC shall not be held responsible for identifying any or all such patent rights.

ISO (www.iso.org/patents) and IEC (<http://patents.iec.ch>) maintain on-line data bases of patents relevant to their standards. Users are encouraged to consult the databases for the most up to date information concerning patents.

PROGRAMMABLE CONTROLLERS –

Part 9: Single-drop digital communication interface for small sensors and actuators (SDCI)

1 Scope

This part of IEC 61131 specifies a single-drop digital communication interface technology for small sensors and actuators SDCI (commonly known as IO-Link™²), which extends the traditional digital input and digital output interfaces as defined in IEC 61131-2 towards a point-to-point communication link. This technology enables the transfer of parameters to Devices and the delivery of diagnostic information from the Devices to the automation system.

This technology is mainly intended for use with simple sensors and actuators in factory automation, which include small and cost-effective microcontrollers.

This part specifies the SDCI communication services and protocol (physical layer, data link layer and application layer in accordance with the ISO/OSI reference model) for both SDCI Masters and Devices.

This part also includes EMC test requirements.

This part does not cover communication interfaces or systems incorporating multiple point or multiple drop linkages, or integration of SDCI into higher level systems such as fieldbuses.

2 Normative references

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60947-5-2, *Low-voltage switchgear and controlgear – Part 5-2: Control circuit devices and switching elements – Proximity switches*

IEC 61000-4-2, *Electromagnetic compatibility (EMC) – Part 4-2: Testing and measurement techniques – Electrostatic discharge immunity test*

IEC 61000-4-3, *Electromagnetic compatibility (EMC) – Part 4-3: Testing and measurement techniques – Radiated, radio-frequency, electromagnetic field immunity test*

IEC 61000-4-4, *Electromagnetic compatibility (EMC) – Part 4-4: Testing and measurement techniques – Electrical fast transient/burst immunity test*

IEC 61000-4-5, *Electromagnetic compatibility (EMC) – Part 4-5: Testing and measurement techniques – Surge immunity test*

² IO-Link™ is a trade name of the "IO-Link Consortium". This information is given for the convenience of users of this international Standard and does not constitute an endorsement by IEC of the trade name holder or any of its products. Compliance to this standard does not require use of the registered logos for IO-Link™. Use of the registered logos for IO-Link™ requires permission of the "IO-Link Consortium".

IEC 61000-4-6, *Electromagnetic compatibility (EMC) – Part 4-6: Testing and measurement techniques – Immunity to conducted disturbances, induced by radio-frequency fields*

IEC 61000-4-11, *Electromagnetic compatibility (EMC) – Part 4-11: Testing and measurement techniques – Voltage dips, short interruptions and voltage variations immunity tests*

IEC 61000-6-2, *Electromagnetic compatibility (EMC) – Part 6-2: Generic standards – Immunity for industrial environments*

IEC 61000-6-4, *Electromagnetic compatibility (EMC) – Part 6-4: Generic standards – Emission standard for industrial environments*

IEC 61076-2-101, *Connectors for electronic equipment – Product requirements – Part 2-101: Circular connectors – Detail specification for M12 connectors with screw-locking*

IEC 61131-1, *Programmable controllers – Part 1: General information*

IEC 61131-2, *Programmable controllers – Part 2: Equipment requirements and tests*

IEC/TR 62390, *Common automation device – Profile guideline*

ISO/IEC 646:1991, *Information technology – ISO 7-bit coded character set for information interchange*

ISO/IEC 2022, *Information technology – Character code structure and extension techniques*

ISO/IEC 10646, *Information technology – Universal Multiple-Octet Coded Character Set (UCS)*

ISO/IEC 10731, *Information technology – Open Systems Interconnection – Basic Reference Model – Conventions for the definition of OSI services*

ISO/IEC 19505 (all parts), *Information technology – Object Management Group Unified Modeling Language (OMG UML)*

ISO 1177, *Information processing – Character structure for start/stop and synchronous character oriented transmission*

IEEE Std 754-2008, *IEEE Standard for Floating-Point Arithmetic*

Internet Engineering Task Force (IETF): RFC 5905 – *Network Time Protocol Version 4: Protocol and Algorithms Specification*; available at < www.ietf.org >

3 Terms, definitions, symbols, abbreviated terms and conventions

3.1 Terms and definitions

For the purposes of this document, the terms and definitions given in IEC 61131-1 and IEC 61131-2, as well as the following apply.

3.1.1 address

part of the M-sequence control to reference data within data categories of a communication channel